

Notice of References Cited	Application/Control No. 10/554,032		Applicant(s)/Patent Under Reexamination ACKERMANN-MARKES ET AL.	
	Examiner JEFFREY M. RUTKOWSKI		Art Unit 2419	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,223,218 B1	04-2001	Iijima et al.	709/221
*	B	US-2003/0189905 A1	10-2003	Lee, Chih-Fang	370/254
*	C	US-2004/0042416 A1	03-2004	Ngo et al.	370/254
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
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NON-PATENT DOCUMENTS

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